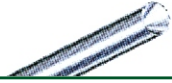
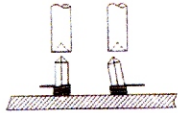


Head Styles



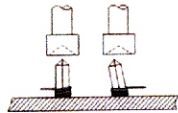
A



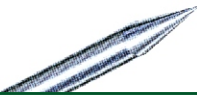
"A" Tip-used to test long leads, terminals, and wire wrap posts.



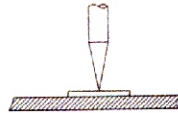
A



"A" Tip-used to test long leads, terminals, and wire wrap posts.



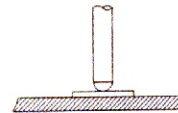
B



"B" Tip-Spear Point used to test lands, pads spear point penetrates thin layers of oxides or contaminations on PCB.



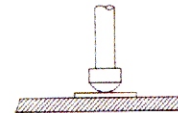
D



"D" Tip-Spherical Radius used to test gold edge fingers and gold pads, leaves no marks or indentations.



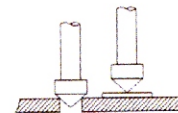
D



"D" Tip-Spherical Radius used to test gold edge fingers and gold pads, leaves no marks or indentations.



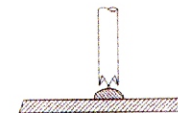
E



"E" Tip-Convex. used to test through holes, pads and lands, gold edge fingers.



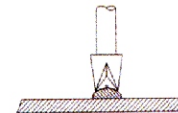
F



"F" Tip-4point Tapered Serrated used to test narrow lands. Will not be contaminated by dust.



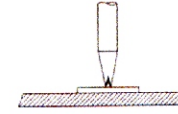
F



"F" Tip-4point Tapered Serrated used to test narrow lands. Will not be contaminated by dust.



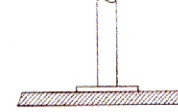
F



"F" Tip-4point Tapered Serrated used to test narrow lands. Will not be contaminated by dust.



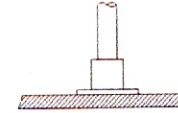
G



"G" Tip-Flat for testing pads and gold edge-fingers [contact assured leaves no marks or indentations.]



G



"G" Tip-Flat for testing pads and gold edge-fingers [contact assured leaves no marks or indentations.]